

FEATURES

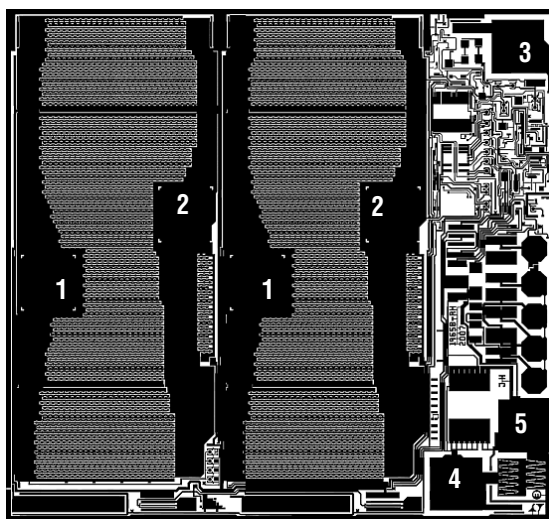
- **Output Current: 0.9A**
- **500 μ A Quiescent Current**
- Adjustable Output from 1.2V to 19.5V
- No Protection Diodes Needed
- < 1 μ A Quiescent Current in Shutdown
- Total Ionizing Dose (TID) Tolerance, per TM1019.8,
- MIL-STD-883 up to:
 - 200kRad (Si), per Condition A, at 50Rads(Si)/sec
 - 100kRad (Si), per Condition D, at 10mRads(Si)/sec
 - ELDRS Pass 100kRad(Si)
- MIL-PRF-38535 Class V Compliant

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DESCRIPTION

The **RH1965MK** is a 0.9A low noise, low dropout linear regulator with a PNP pass transistor, requiring only a single supply for operation. Operating quiescent current is 500 μ A, reducing to less than 1 μ A in shutdown. Output voltage ranges from 1.2V to 19.5V. A small 10 μ F capacitor on the output with an ESR of less than 1 Ω is adequate to ensure stability. Applications with large output load transients require a larger output capacitor value to minimize output voltage change. Input circuitry ensures output safe operating area with current limiting and thermal shutdown protection. The rated dropout of an RH1965-based part is dependent on the internal bond wire length/resistance. Linear Technology dice element evaluations are based on parts rated for 0.9A output current that are assembled in 4-Lead TO-3 can packages.

DICE PINOUT



PAD FUNCTION

1. OUT
2. IN
3. SHDN
4. ADJ
5. GND

DIE CROSS REFERENCE

LTC® Finished Part Number	Order Part Number
RH1965MK	RH1965MK DICE
RH1965MK	RH1965MK DWF*

Please refer to LTC standard product data sheet for other applicable product information.

*DWF = DICE in wafer form.

71mils × 66mils,
 Backside metal: Alloyed gold (K) layer
 Backside potential: GND

RH1965MK DICE/DWF

ABSOLUTE MAXIMUM RATINGS

(Note 1)

IN Pin Voltage	±22V
OUT Pin Voltage	±22V
Input to Output Differential Voltage (Note 2)	±22V
ADJ Pin Voltage	±9V
SHDN Pin Voltage	±22V
Output Short-Circuit Duration	Indefinite
Operating Junction Temperature	
Range (Notes 3, 5, 13)	-55°C to 125°C
Storage Temperature Range	-65°C to 150°C

TABLE 1: DICE/DWF ELECTRICAL TEST LIMITS $T_A = 25^\circ\text{C}$ (Notes 3, 14, 15, 16)

PARAMETER	CONDITIONS	MIN	MAX	UNITS
ADJ Pin Voltage (Notes 4, 5)	$V_{IN} = 2.1\text{V}$, $I_{LOAD} = 1\text{mA}$	1.182	1.218	V
Line Regulation	$\Delta V_{IN} = 2.1\text{V}$ to 20V , $I_{LOAD} = 1\text{mA}$ (Note 4)		5	mV
Load Regulation	$V_{IN} = 2.3\text{V}$, $\Delta I_{LOAD} = 1\text{mA}$ to 50mA (Note 4)		7	mV
Dropout Voltage	$I_{LOAD} = 1\text{mA}$		0.08	V
$V_{IN} = V_{OUT(NOMINAL)}$ (Notes 6, 7, 12)	$I_{LOAD} = 50\text{mA}$		0.16	V
GND Pin Current	$I_{LOAD} = 0\text{mA}$		0.7	mA
$V_{IN} = V_{OUT(NOMINAL)} + 1\text{V}$	$I_{LOAD} = 1\text{mA}$		1	mA
(Notes 6, 8)	$I_{LOAD} = 100\text{mA}$		4.5	mA
ADJ Pin Bias Current (Notes 4, 9)			4.5	μA
Shutdown Threshold	$V_{OUT} = \text{Off to On}$ $V_{OUT} = \text{On to Off}$	0.43	1.2	V V
SHDN Pin Current (Note 10)	$V_{SHDN} = 0\text{V}$ $V_{SHDN} = 20\text{V}$		1 10	μA μA
Quiescent Current in Shutdown	$V_{IN} = 6\text{V}$, $V_{SHDN} = 0\text{V}$		1	μA
Input Reverse-Leakage Current	$V_{IN} = -20\text{V}$, $V_{OUT} = 0\text{V}$		1	mA
Reverse-Output Current (Note 11)	$V_{OUT} = 1.2\text{V}$, $V_{IN} = 0\text{V}$ (Note 4)		400	μA

TABLE 2: ELECTRICAL CHARACTERISTICS (Preirradiation) (Notes 3, 15, 16)

PARAMETER	CONDITIONS	T _A = 25°C		SUB-GROUP	-55°C < T _A < 125°C		SUB-GROUP	UNITS
		MIN	MAX		MIN	MAX		
Minimum Input Voltage (Notes 4, 12)	I _{LOAD} = 0.9A		2.3	1		2.3	2, 3	V
ADJ Pin Voltage (Notes 4, 5)	V _{IN} = 2.1V, I _{LOAD} = 1mA	1.182	1.218	1	1.164	1.236	2, 3	V
Line Regulation	ΔV _{IN} = 2.1V to 20V, I _{LOAD} = 1mA (Note 4)		6	1		8	2, 3	mV
Load Regulation	V _{IN} = 2.3V, ΔI _{LOAD} = 1mA to 0.9A (Note 4)		8	1		16	2, 3	mV
Dropout Voltage V _{IN} = V _{OUT(NOMINAL)} (Notes 6, 7, 12)	I _{LOAD} = 1mA		80	1		140	2, 3	mV
	I _{LOAD} = 100mA		185	1		295	2, 3	mV
	I _{LOAD} = 500mA		300	1		430	2, 3	mV
	I _{LOAD} = 0.9A		435	1		600	2, 3	mV
GND Pin Current V _{IN} = V _{OUT(NOMINAL)} + 1V (Notes 6, 8)	I _{LOAD} = 0mA		0.85	1		1.1	2, 3	mA
	I _{LOAD} = 1mA		1.1	1		1.5	2, 3	mA
	I _{LOAD} = 100mA		4.6	1		5.5	2, 3	mA
	I _{LOAD} = 500mA		16.5	1		20	2, 3	mA
	I _{LOAD} = 0.9A		30	1		38	2, 3	mA
Output Voltage Noise	V _{OUT} = 2.5V, C _{OUT} = 10μF, I _{LOAD} = 0.9A, BW = 10Hz to 100kHz		TYP = 40	1				μV _{RMS}
ADJ Pin Bias Current (Notes 4, 9)			4.5	1		4.5		μA
Shutdown Threshold	V _{OUT} = Off to On			1		2	2, 3	V
	V _{OUT} = On to Off	0.37	1.5		0.2			V
SHDN Pin Current (Note 10)	V _{SHDN} = 0V		1	1				μA
	V _{SHDN} = 20V		10					μA
Quiescent Current in Shutdown	V _{IN} = 6V, V _{SHDN} = 0V		1	1				μA
Ripple Rejection	V _{IN} - V _{OUT} = 1.5V (AVG), V _{RIPPLE} = 0.5V _{P-P} , f _{RIPPLE} = 120Hz, I _{LOAD} = 0.75A	57		1				dB
Current Limit (Note 6)	V _{IN} = V _{OUT(NOMINAL)} + 1V, ΔV _{OUT} = -0.1V	1.0		1	1.0		2, 3	A
Input Reverse-Leakage Current	V _{IN} = -20V, V _{OUT} = 0V		1	1				mA
Reverse-Output Current (Note 11)	V _{OUT} = 1.2V, V _{IN} = 0V (Note 4)		400	1				μA

TABLE 3: ELECTRICAL CHARACTERISTICS (Postirradiation) $T_A = 25^\circ\text{C}$ (Notes 3, 15, 16)

PARAMETER	CONDITIONS	10kRads (Si)		20kRads (Si)		50kRads (Si)		100kRads (Si)		200kRads (Si)		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Minimum Input Voltage (Notes 4, 12)	$I_{LOAD} = 0.9\text{A}$	2.3		2.3		2.3		2.3		2.3		V
ADJ Pin Voltage (Notes 4, 5)	$V_{IN} = 2.1\text{V}$, $I_{LOAD} = 1\text{mA}$	1.176	1.224	1.176	1.224	1.176	1.224	1.176	1.224	1.176	1.224	V
Line Regulation (Note 4)	$\Delta V_{IN} = 2.1\text{V}$ to 20V , $I_{LOAD} = 1\text{mA}$	6		6		6		6		6		mV
Load Regulation	$V_{IN} = 2.3\text{V}$, $\Delta I_{LOAD} = 1\text{mA}$ to 0.9A (Note 4)	8		8		9		10		12		mV
Dropout Voltage (Notes 6, 7, 12)	$I_{LOAD} = 1\text{mA}$	80		80		80		80		80		mV
	$I_{LOAD} = 100\text{mA}$	185		185		186		188		190		mV
	$I_{LOAD} = 500\text{mA}$	300		300		305		310		320		mV
	$I_{LOAD} = 0.9\text{A}$	435		440		450		455		465		mV
GND Pin Current $V_{IN} = V_{OUT(\text{NOMINAL})} + 1\text{V}$ (Notes 6, 8)	$I_{LOAD} = 0\text{mA}$	0.85		0.85		0.85		0.85		0.85		mA
	$I_{LOAD} = 1\text{mA}$	1.1		1.1		1.1		1.1		1.1		mA
	$I_{LOAD} = 100\text{mA}$	4.8		4.9		5.2		6		7		mA
	$I_{LOAD} = 500\text{mA}$	17		18		19		21		25		mA
	$I_{LOAD} = 0.9\text{A}$	31		32		34		38		45		mA
Output Voltage Noise	$V_{OUT} = 2.5\text{V}$, $C_{OUT} = 10\mu\text{F}$, $I_{LOAD} = 0.9\text{A}$, $\text{BW} = 10\text{Hz}$ to 100kHz	TYP = 40		TYP = 40		TYP = 40		TYP = 40		TYP = 40		μV_{RMS}
ADJ Pin Bias Current (Notes 4, 9)		4.5		4.5		4.5		4.5		4.5		μA
Shutdown Threshold	$V_{OUT} = \text{Off to On}$ $V_{OUT} = \text{On to Off}$	0.37	1.5	0.37	1.5	0.37	1.5	0.37	1.5	0.37	1.5	V V
SHDN Pin Current (Note 10)	$V_{SHDN} = 0\text{V}$	1		1		1		1		1		μA
	$V_{SHDN} = 20\text{V}$	10		10		10		10		10		μA
Quiescent Current in Shutdown	$V_{IN} = 6\text{V}$, $V_{SHDN} = 0\text{V}$	1		1		1		1		1		μA
Ripple Rejection	$V_{IN} = 2.7\text{V} + 0.5\text{V}_{\text{P-P}}$, $V_{OUT} = 1.2\text{V}$ $f_{\text{RIPPLE}} = 120\text{Hz}$, $I_{LOAD} = 0.75\text{A}$	56		55		54		52		50		dB
Current Limit	$V_{IN} = V_{OUT(\text{NOMINAL})} + 1\text{V}$, $\Delta V_{OUT} = -0.1\text{V}$	1.0		1.0		1.0		1.0		1.0		A
Input Reverse-Leakage Current	$V_{IN} = -20\text{V}$, $V_{OUT} = 0\text{V}$	1		1		1		1		1		mA
Reverse-Output Current (Note 11)	$V_{OUT} = 1.2\text{V}$, $V_{IN} = 0\text{V}$ (Note 4)	400		400		400		400		400		μA

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: Absolute maximum input to output differential voltage is not achievable with all combinations of rated IN pin and OUT pin voltages. With the IN pin at 22V, the OUT pin may not be pulled below 0V. The total measured voltage from IN to OUT must not exceed $\pm 22\text{V}$.

Note 3: The RH1965MK DICE is tested and specified under pulse load conditions such that $T_J \cong T_A$.

Note 4: The RH1965MK DICE is tested and specified for these conditions with the ADJ pin connected to the output.

Note 5: Maximum junction temperature limits operating conditions. The regulated output voltage specification does not apply for all possible combinations of input voltage and output current. Limit the output current range if operating at the maximum input voltage. Limit the input-to-output voltage differential if operating at the maximum output current.

Note 6: To satisfy minimum input voltage requirements, the RH1965MK DICE is tested and specified for these conditions with an external resistor divider (bottom 4.02k, top 4.32k) for an output voltage of 2.5V. The external resistor divider adds 300 μA of output DC load current. This external current is not factored into GND pin current.

Note 7: Dropout voltage is the minimum input-to-output voltage differential needed to maintain regulation at a specified output current. In dropout, the output voltage equals: $(V_{IN} - V_{\text{DROPOUT}})$.

ELECTRICAL CHARACTERISTICS

Note 8: GND pin current is tested with $V_{IN} = V_{OUT(NOMINAL)} + 1V$ and a current source load. GND pin current increases slightly in dropout.

Note 9: ADJ pin bias current flows into the ADJ pin.

Note 10: SHDN pin current flows into the SHDN pin.

Note 11: Reverse-output current is tested with the IN pin grounded and the OUT pin forced to 1.2V. This current flows into the OUT pin and out of the GND pin.

Note 12: The minimum input voltage specification limits the dropout voltage under some output voltage/load conditions

Note 13: This IC includes overtemperature protection that is intended to protect the device during momentary overload conditions. Junction temperature exceeds the maximum junction temperature when

overtemperature protection is active. Continuous operation above the specified maximum operating junction temperature may impair device reliability.

Note 14: Dice are probe tested at 25°C to the limits shown in Table 1. Except for high current tests, dice are tested under low current conditions which assure full load current specifications when assembled.

Note 15: Dice that are not qualified by Linear Technology with a can sample are guaranteed to meet specifications of Table 1 only. Dice qualified by Linear Technology with a can sample meet specifications in all tables.

Note 16: Please refer to the LT1965 standard product data sheet for Typical Performance Characteristics, Pin Functions, Applications Information, and Typical Applications.

TABLE 4. POST BURN-IN ENDPOINTS AND DELTA LIMIT REQUIREMENTS $T_A = 25^\circ\text{C}$

PARAMETER	CONDITIONS	ENDPOINT LIMITS		DELTA LIMITS		UNITS
		MIN	MAX	MIN	MAX	
ADJ Pin Voltage (Notes 4, 5)	$V_{IN} = 2.1V, I_{LOAD} = 1mA$	1.182	1.218	-0.010	0.010	V
ADJ Pin Bias Current (Notes 4, 9)			4.5	-0.4	0.4	μA

TABLE 5. ELECTRICAL TEST REQUIREMENTS

MIL-STD-883 TEST REQUIREMENTS	SUBGROUP
Final Electrical Test Requirements (Method 5004)	1*, 2, 3
Group A Test Requirements (Method 5005)	1, 2, 3
Group B and D for Class S, End Point Electrical Parameters (Method 5005)	1, 2, 3

*PDA applies to subgroup 1. See PDA Test Notes.

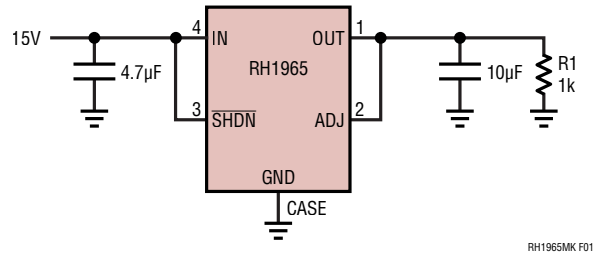
PDA Test Notes

The PDA is specified as 5% based on failures from group A, subgroup 1, tests after cooldown as the final electrical test in accordance with method 5004 of MIL-STD-883. The verified failures of group A, subgroup 1, after burn-in divided by the total number of devices submitted for burn-in in that lot shall be used to determine the percent for the lot.

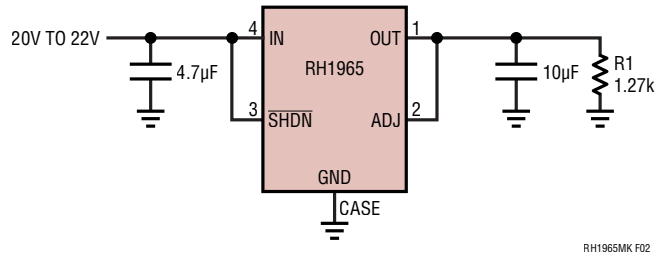
Linear Technology Corporation reserves the right to test to tighter limits than those given.

RH1965MK DICE/DWF

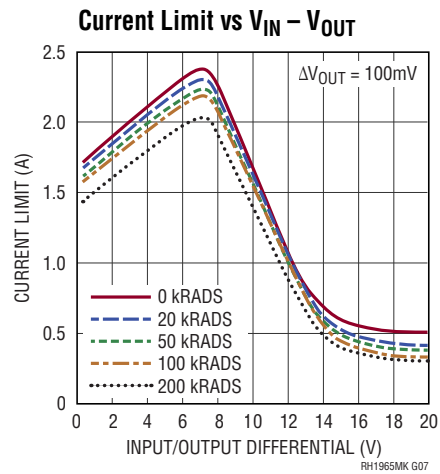
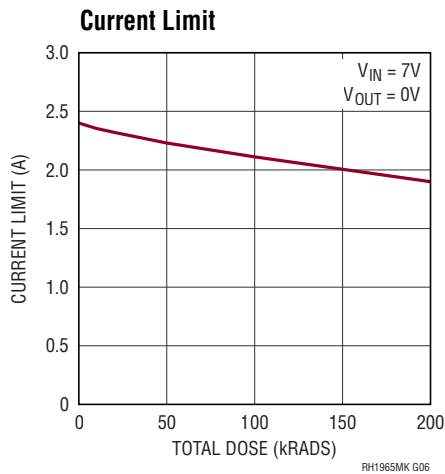
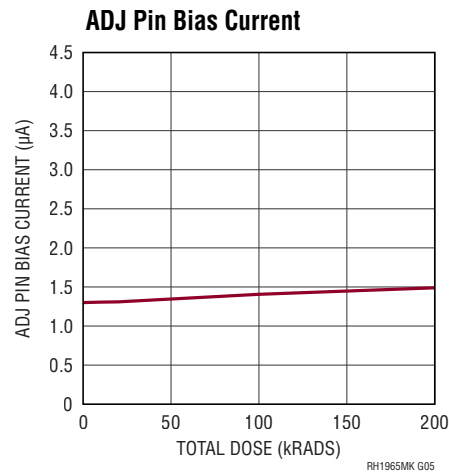
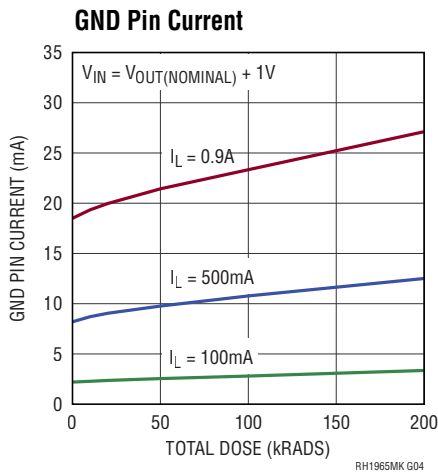
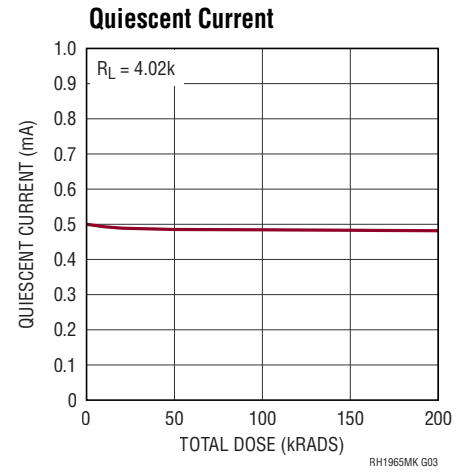
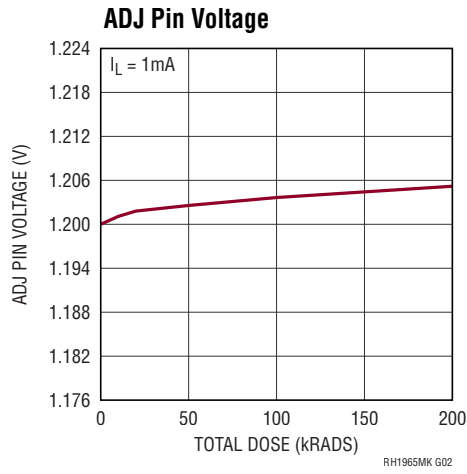
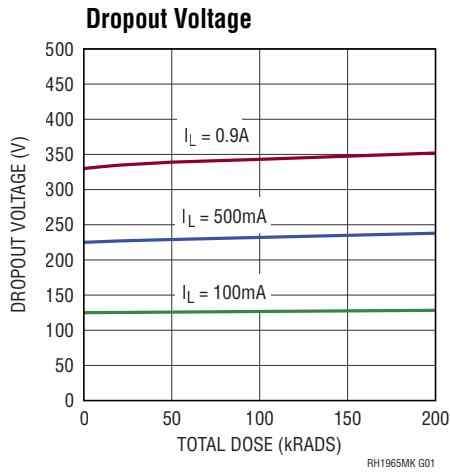
TOTAL DOSE BIAS CIRCUIT



BURN-IN CIRCUIT



TYPICAL PERFORMANCE CHARACTERISTICS $T_A = 25^\circ\text{C}$



RH1965MK DICE/DWF

TYPICAL PERFORMANCE CHARACTERISTICS $T_A = 25^\circ\text{C}$

